

# Silicon Carbide (SiC) Cascode JFET - EliteSiC, Power N-Channel, TO247-3, 650 V, 42 mohm

# **UF3C065040K3S**

## Description

**onsemi**'s cascode products co-package its high-performance G3 SiC JFETs with a cascode optimized MOSFET to produce the only standard gate drive SiC device in the market today. This series exhibits ultra-low gate charge, but also the best reverse recovery characteristics of any device of similar ratings. These devices are excellent for switching inductive loads when used with recommended RC-snubbers, and any application requiring standard gate drive.

#### **Features**

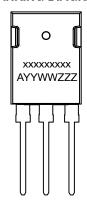
- Typical On-resistance  $R_{DS(on),typ}$  of 42 m $\Omega$
- Maximum Operating Temperature of 175 °C
- Excellent Reverse Recovery
- Low Gate Charge
- Low Intrinsic Capacitance
- ESD Protected, HBM Class 2
- Very Low Switching Losses (required RC-snubber loss negligible under typical operating conditions)
- This Device is Pb-Free, Halogen Free and is RoHS Compliant

#### **Typical Applications**

- EV Charging
- PV Inverters
- Switch Mode Power Supplies
- Power Factor Correction Modules
- Motor Drives
- · Induction Heating



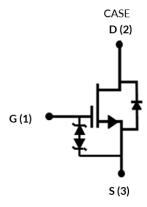
#### MARKING DIAGRAM



xxxxxxxxx = Specific Device Number A = Assembly Location

YY = Year WW = Work Week ZZZ = Lot ID

#### **PIN CONNECTIONS**



### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 9 of this data sheet.

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### **MAXIMUM RATINGS**

Parameter	Symbol	Test Conditions	Value	Unit
Drain-source Voltage	$V_{DS}$		650	V
Gate-source Voltage	$V_{GS}$	DC	-25 to +25	V
Continuous Drain Current (Note 1)	I <sub>D</sub>	T <sub>C</sub> = 25 °C	54	Α
		T <sub>C</sub> = 100 °C	40	Α
Pulsed Drain Current (Note 2)	I <sub>DM</sub>	T <sub>C</sub> = 25 °C	125	Α
Single Pulsed Avalanche Energy (Note 3)	E <sub>AS</sub>	L = 15 mH, I <sub>AS</sub> = 3.19 A	76	mJ
Power Dissipation	P <sub>tot</sub>	T <sub>C</sub> = 25 °C	326	W
Maximum Junction Temperature	$T_{J,max}$		175	°C
Operating and Storage Temperature	T <sub>J</sub> , T <sub>STG</sub>		-55 to 175	°C
Max. Lead Temperature for Soldering, 1/8" from Case for 5 Seconds	TL		250	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Limited by  $T_{J,max}$ 2. Pulse width  $t_p$  limited by  $T_{J,max}$ 3. Starting  $T_J = 25 \, ^{\circ}C$ 

### THERMAL CHARACTERISTICS

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$		-	0.35	0.46	°C/W

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = +25 °C unless otherwise specified)

Parameter	Symbol	Test Conditi	ons	Min	Тур	Max	Unit
TYPICAL PERFORMANCE - STATIC							
Drain-source Breakdown Voltage	BV <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA		650	-	_	V
Total Drain Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 \	/, T <sub>J</sub> = 25 °C	-	0.7	150	μΑ
		V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 \	/, T <sub>J</sub> = 175°C	-	10	-	
Total Gate Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, T <sub>J</sub> = 25 °C, V <sub>GS</sub> = -20 V/ +20 V		-	6	±20	μΑ
Drain-source On-resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 12 V, I <sub>D</sub> = 40 A	T <sub>J</sub> = 25 °C	-	42	52	mΩ
			T <sub>J</sub> = 125 °C	-	59	-	
			T <sub>J</sub> = 175 °C	-	78	-	
Gate Threshold Voltage	V <sub>G(th)</sub>	$V_{DS} = 5 \text{ V}, I_{D} = 10 \text{ mA}$		4	5	6	V
Gate Resistance	$R_{G}$	f = 1 MHz, open drain		-	4.5	-	Ω
TYPICAL PERFORMANCE - REVERSE DIC	DE						
Diode Continuous Forward Current (Note 4)	I <sub>S</sub>	T <sub>C</sub> = 25 °C		-	-	54	Α
Diode Pulse Current (Note 5)	I <sub>S,pulse</sub>	T <sub>C</sub> = 25 °C		-	-	125	Α
Forward Voltage	$V_{FSD}$	V <sub>GS</sub> = 0 V, I <sub>F</sub> = 20 A, T	V <sub>GS</sub> = 0 V, I <sub>F</sub> = 20 A, T <sub>J</sub> = 25 °C		1.5	1.75	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 20 A, T	<sub>J</sub> = 175 °C	-	1.8	-	
Reverse Recovery Charge	Q <sub>rr</sub>	$V_{DS}$ = 400 V, $I_F$ = 40 A, $V_{GS}$ = -5 V, $R_{G-EXT}$ = 20 $\Omega$ , $di/dt$ = 1100 A/ $\mu$ s, $T_J$ = 25 °C		-	138	-	nC
Reverse Recovery Time	t <sub>rr</sub>			-	38	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	$V_{DS} = 400 \text{ V}, \ I_F = 40 \text{ A}, \ V_{GS} = -5 \text{ V}, \ R_{G\_EXT} = 20 \ \Omega, \ di/dt = 1100 \ A/\mu s, \ T_J = 150 \ ^{\circ} C$		-	137	-	nC
Reverse Recovery Time	t <sub>rr</sub>			-	38	-	ns

# **ELECTRICAL CHARACTERISTICS** ( $T_J = +25$ °C unless otherwise specified) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
TYPICAL PERFORMANCE - DYNAMIC	•			•		•
Input Capacitance	C <sub>iss</sub>	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V},$	_	1500	_	pF
Output Capacitance	C <sub>oss</sub>	f = 100 kHz	-	200	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		_	2.2	-	
Effective Output Capacitance, Energy Related	C <sub>oss(er)</sub>	$V_{DS} = 0 \text{ V to } 400 \text{ V}, V_{GS} = 0 \text{ V}$	-	146	-	pF
Effective Output Capacitance, Time Related	C <sub>oss(tr)</sub>		_	325	-	pF
C <sub>oss</sub> Stored Energy	E <sub>oss</sub>	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V	-	11.7	-	μJ
Total Gate Charge	$Q_{G}$	$V_{DS} = 400 \text{ V}, I_{D} = 40 \text{ A},$	-	51	-	nC
Gate-drain Charge	$Q_{GD}$	V <sub>GS</sub> = −5 V to 15 V	-	11	-	
Gate-source Charge	Q <sub>GS</sub>		-	19	-	
Turn-on Delay Time	t <sub>d(on)</sub>	$V_{DS} = 400 \text{ V}, I_{D} = 40 \text{ A},$	-	35	-	ns
Rise Time	t <sub>r</sub>	Gate Driver =–5 V to +15 V, Turn-on $R_{G,EXT}$ = 1.8 $\Omega$ ,	-	24	-	
Turn-off Delay Time	t <sub>d(off)</sub>	Turn-off $R_{G,EXT} = 22 \Omega$ , Inductive Load, FWD: Same Device With $V_{GS} = -5 V$ , $R_{G} = 22 \Omega$ , RC Snubber: $R_{S} = 5 \Omega$ , $R_{S} = 150  \text{pF}$ , $R_{S} = 25  \text{C}$	-	57	-	
Fall Time	t <sub>f</sub>		-	14	-	
Turn-on Energy Including R <sub>S</sub> Energy (Note 6)	E <sub>ON</sub>		-	500	-	μJ
Turn-off Energy Including R <sub>S</sub> Energy (Note 6)	E <sub>OFF</sub>		-	118	-	
Total Switching Energy Including R <sub>S</sub> Energy (Note 6)	E <sub>TOTAL</sub>		-	618	-	
Snubber R <sub>S</sub> Energy During Turn-on	E <sub>RS_ON</sub>		-	1.7	-	1
Snubber R <sub>S</sub> Energy During Turn-off	E <sub>RS_OFF</sub>		-	4.5	-	
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DS</sub> = 400 V, I <sub>D</sub> = 40 A,	-	35	-	ns
Rise Time	t <sub>r</sub>	Gate Driver =–5 V to +15 V, Turn-on $R_{G,EXT}$ = 1.8 $\Omega$ ,	-	22	-	
Turn-off Delay Time	t <sub>d(off)</sub>	Turn-off $R_{G,EXT}$ = 22 $\Omega$ , Inductive Load,	-	60	-	
Fall Time	t <sub>f</sub>	FWD: Same Device With	-	13	-	1
Turn-on Energy Including R <sub>S</sub> Energy (Note 6)	E <sub>ON</sub>	$V_{GS}$ = -5 V, R <sub>G</sub> = 22 Ω, RC Snubber: R <sub>S</sub> = 5 Ω, C <sub>S</sub> = 150 pF, T <sub>J</sub> = 150 °C	-	479	-	μJ
Turn-off Energy Including R <sub>S</sub> Energy (Note 6)	E <sub>OFF</sub>		-	124	-	
Total Switching Energy Including R <sub>S</sub> Energy (Note 6)	E <sub>TOTAL</sub>		-	603	-	
Snubber R <sub>S</sub> Energy During Turn-on	E <sub>RS_ON</sub>		_	1.8	-	1
Snubber R <sub>S</sub> Energy During Turn-off	E <sub>RS_OFF</sub>	1	_	5.3	_	1

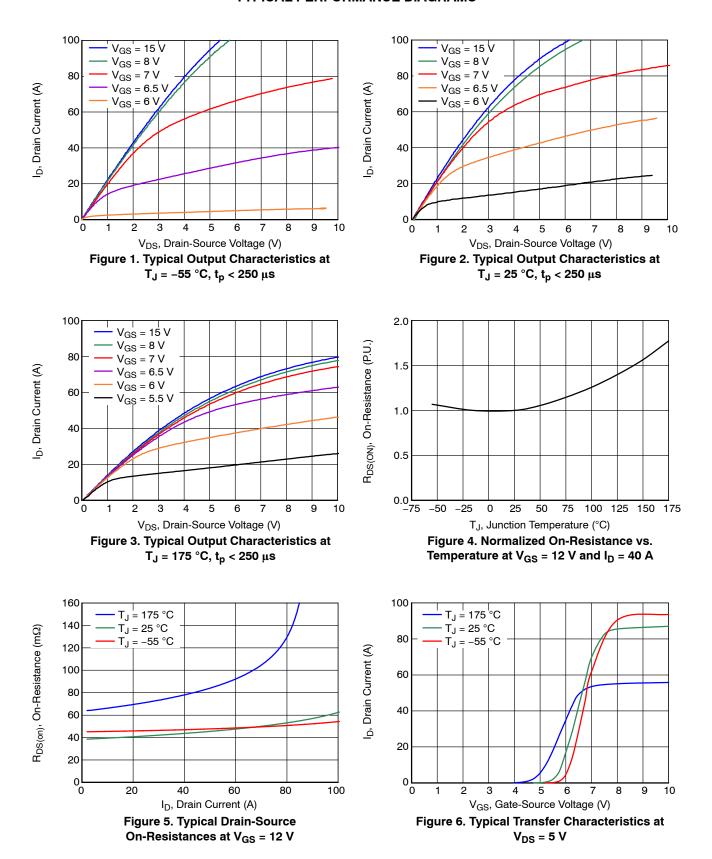
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Limited by T<sub>J,max</sub>

5. Pulse width t<sub>p</sub> limited by T<sub>J,max</sub>

6. The switching performance are evaluated with a RC snubber circuit as shown in Figure 29.

#### **TYPICAL PERFORMANCE DIAGRAMS**



### TYPICAL PERFORMANCE DIAGRAMS (continued)

V<sub>GS</sub>, Gate-Source Voltage (V)

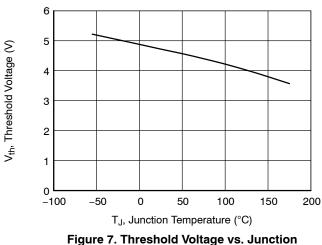


Figure 7. Threshold Voltage vs. Junction Temperature at  $V_{DS} = 5 \text{ V}$  and  $I_D = 10 \text{ mA}$ 

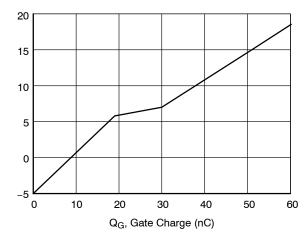


Figure 8. Typical Gate Charge at  $V_{DS} = 400 \text{ V}$  and  $I_{D} = 40 \text{ A}$ 

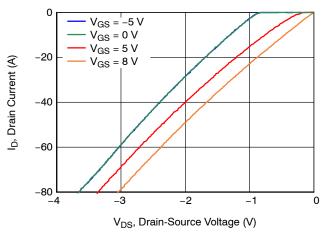


Figure 9.  $3^{rd}$  Quadrant Characteristics at  $T_J = -55$  °C

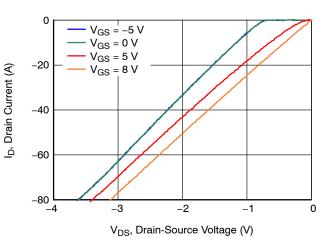


Figure 10.  $3^{rd}$  Quadrant Characteristics at  $T_J = 25$  °C

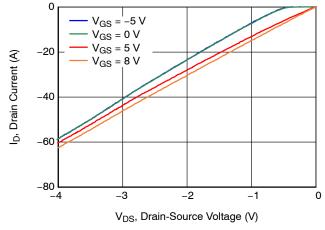


Figure 11.  $3^{rd}$  Quadrant Characteristics at  $T_J = 175$  °C

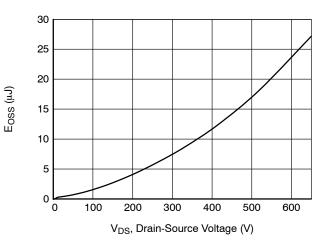


Figure 12. Typical Stored Energy in  $C_{OSS}$  at  $V_{GS} = 0 \text{ V}$ 

### TYPICAL PERFORMANCE DIAGRAMS (continued)

ID, DC Drain Current (A)

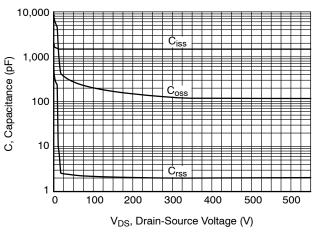


Figure 13. Typical Capacitances at f = 100 kHz and  $V_{GS} = 0 \text{ V}$ 

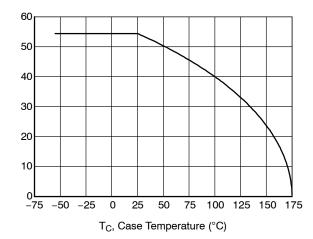


Figure 14. DC Drain Current Derating

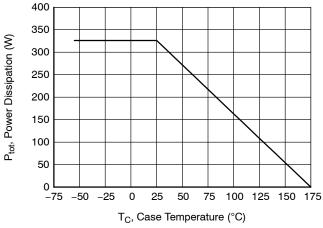


Figure 15. Total Power Dissipation

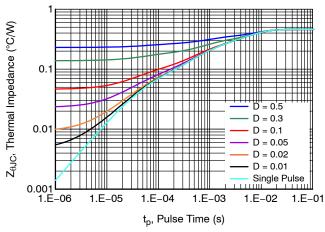


Figure 16. Maximum Transient Thermal Impedance

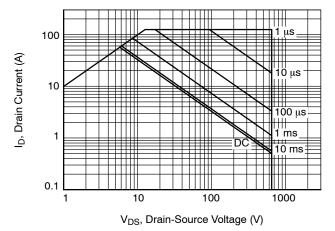


Figure 17. Safe Operation Area at  $T_C = 25$  °C, D = 0, Parameter  $t_p$ 

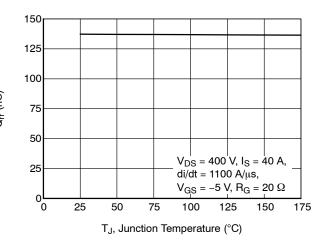
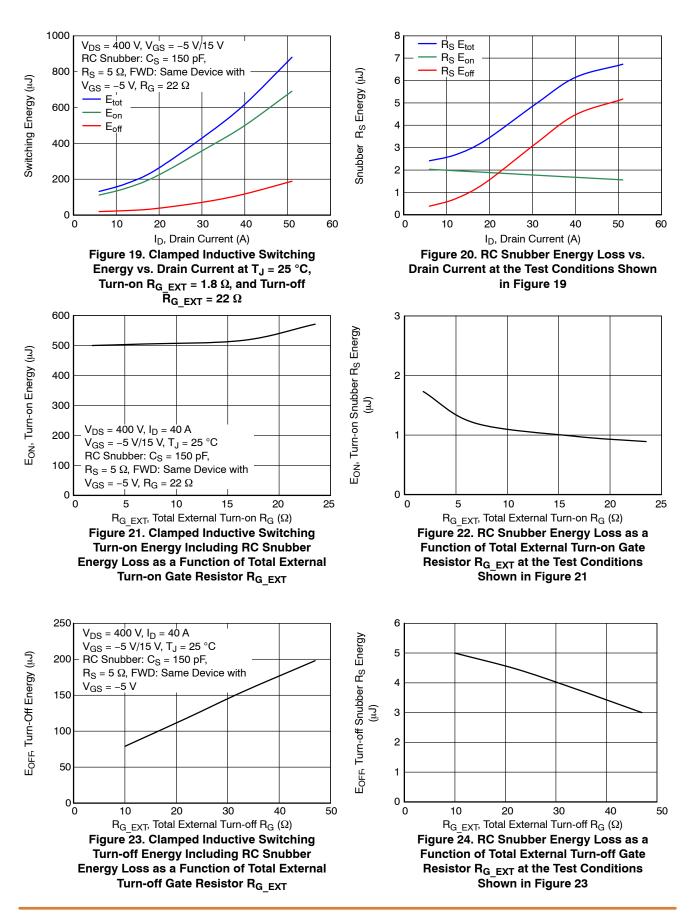


Figure 18. Reverse Recovery Charge Q<sub>rr</sub> vs. Junction Temperature

#### TYPICAL PERFORMANCE DIAGRAMS (continued)



# TYPICAL PERFORMANCE DIAGRAMS (continued)

Switching R<sub>S</sub> Energy (μJ)

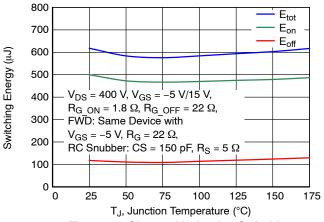


Figure 25. Clamped Inductive Switching Energy Including RC Snubber Energy Loss as a Function of Junction Temperature at  $I_D = 40 \text{ A}$ 

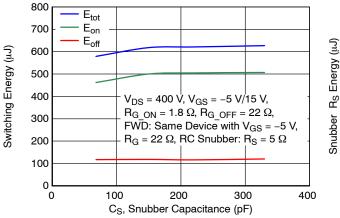


Figure 27. Clamped Inductive Switching Energy Including RC Snubber Energy Loss as a Function of Snubber Capacitance at  $I_D$  = 40 A and  $T_J$  = 25 °C

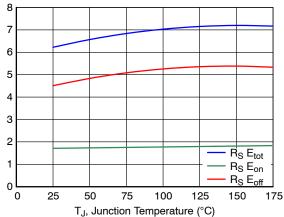


Figure 26. RC Snubber Energy Loss as a Function of Junction Temperature at the Test Conditions Shown in Figure 25

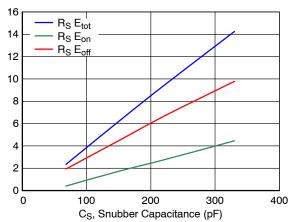


Figure 28. RC Snubber Energy Loss as a Function of Snubber Capacitance at the Test Conditions Shown in Figure 27

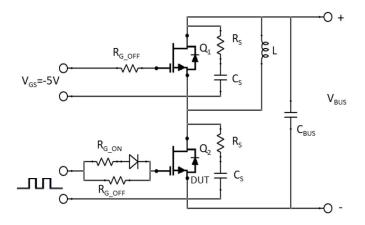


Figure 29. Clamped Inductive Load Switching Test Circuit With An RC Snubber (RS = 5  $\Omega$  and CS = 150 pF)

#### **APPLICATIONS INFORMATION**

SiC cascodes are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ( $R_{DS(on)}$ ), output capacitance ( $C_{oss}$ ), gate charge ( $Q_g$ ), and reverse recovery charge ( $Q_{rr}$ ) leading to low conduction and switching losses. The SiC cascodes also provide excellent reverse conduction

capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.onsemi.com.

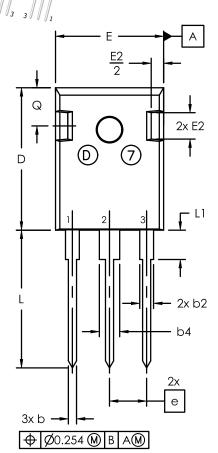
#### **ORDERING INFORMATION**

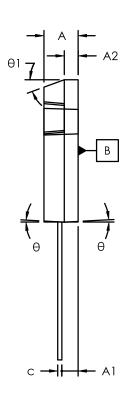
Part Number	Marking	Package	Shipping
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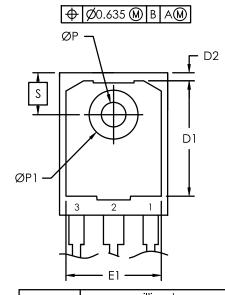




**DATE 14 APR 2025** 







SYM	millimeters					
31701	MIN	NOM	MAX			
Α	4.70	5.03	5.31			
A1	2.21	2.40	2.59			
A2	1.50	2.03	2.49			
b	0.99	1.20	1.40			
b2	1.65	2.03	2.39			
b4	2.59	3.00	3.43			
c D	0.38	0.60	0.89			
D	20.70	20.96	21.46			
D1	13.08	ı	ı			
D2	0.51	1.19	1.35			
Е	15.49	15.90	16.26			
е		5.44 BSC				
E1	13.00	13.30	13.60			
E2	3.43	3.89	5.20			
L	19.62	20.27	20.32			
L1	ı	ı	4.50			
ØP	3.40	3.60	3.80			
ØP1	7.06	7.19	7.39			
Q	5.38	5.62	6.20			
S	6.15 BSC					
θ	3°					
θ1	20°					
θ2	10°					

# θ2

#### NOTE:

- 1. Dimensioning and tolerancing as per ASME Y14.5 2018
- 2. Controlling dimension: millimeters
- 3. Package Outline in compliance with JEDEC standard var. AD.
- 4. Dimensions D & E does not include mold flash.
- 5. ØP to have max draft angle of 1.7° to the top with max. hole diameter of 3.91mm.

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DESCRIPTION:	TO247-3 15.90x20.96x5.03, 5.44P		PAGE 1 OF 1	

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